Notice of References Cited	Application/Control No. 10/567,698	Applicant(s)/Patent Under Reexamination ABEDI, SAIED		
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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0012385	01-2002	Yun et al.	375/146
*	В	US-2002/0072372	06-2002	Tsutsumi et al.	455/442
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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